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May 2014

FDMA8878

Single N-Channel Power Trench[®] MOSFET 30 V, 9.0 A, 16 m Ω

Features

- Max $r_{DS(on)} = 16 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 9.0 \text{ A}$
- Max $r_{DS(on)}$ = 19 m Ω at V_{GS} = 4.5 V, I_D = 8.5 A
- High performance trench technology for extremely low r_{DS(on)}
- Fast switching speed
- RoHS Compliant

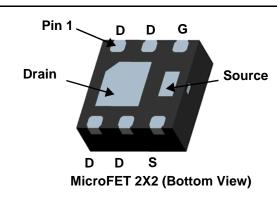
General Description

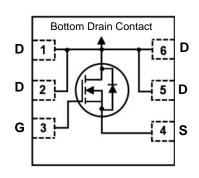
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been optimized for $r_{DS(on)}$, switching performance.

Application

- DC/DC Buck Converters
- Load Switch in NB
- Notebook Battery Power Management







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage		(Note 3)	±20	V
	Drain Current -Continuous (Package Limited)	T _C = 25 °C		10	
I _D	-Continuous	T _A = 25 °C	(Note 1a)	9.0	Α
	-Pulsed			40	
Б	Power Dissipation	T _A = 25 °C	(Note 1a)	2.4	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1b)	0.9	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	52	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	145	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
878	FDMA8878	MicroFET 2x2	7 "	8 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		26		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.2	1.8	3.0	V
$\Delta V_{GS(th)}$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, referenced to 25 °C		-5		mV/°C
r _{DS(on)}		$V_{GS} = 10 \text{ V}, I_D = 9.0 \text{ A}$		13	16	
	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 8.5 \text{ A}$		16	19	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 9.0 \text{ A}, T_J = 125 ^{\circ}\text{C}$		17	21	
9 _{FS}	Forward Transconductance	V _{DD} = 5 V, I _D = 9.0 A		41		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 6 V	539	720	pF
C _{oss}	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz	172	230	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1011 12	24	35	pF
R_{α}	Gate Resistance		1.3		Ω

Switching Characteristics

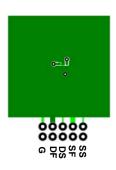
t _{d(on)}	Turn-On Delay Time		6	12	ns
t _r	Rise Time	$V_{DD} = 15 \text{ V}, I_D = 9.0 \text{ A},$	2	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	14	25	ns
t _f	Fall Time		2	10	ns
0	Total Gate Charge	V _{GS} = 0 V to 10 V	8.5	12	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$	4.1	5.8	nC
Q_{gs}	Total Gate Charge	I _D = 9.0 A	1.6		nC
Q_{gd}	Gate to Drain "Miller" Charge		1.2		nC

Drain-Source Diode Characteristics

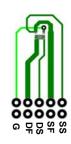
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.0 \text{ A}$ (Note 2)	0.75	1.2	\/
		$V_{GS} = 0 \text{ V}, I_{S} = 9.0 \text{ A}$ (Note 2)	0.86	1.2	V
t _{rr}	Reverse Recovery Time	-I _E = 9.0 A, di/dt = 100 A/μs	16	28	ns
Q _{rr}	Reverse Recovery Charge	1F = 9.0 A, αι/αι = 100 A/μS	4	10	nC

NOTES:

 $R_{0,C}$ is design while $R_{0,C}$ is determined by the user's board design.



a. 52 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 145 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0 %.
- 3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

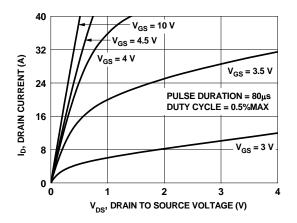


Figure 1. On Region Characteristics

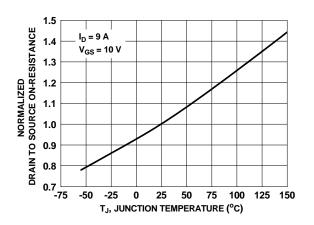


Figure 3. Normalized On Resistance vs Junction Temperature

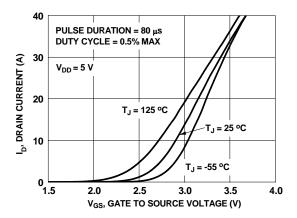


Figure 5. Transfer Characteristics

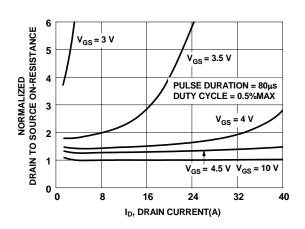


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

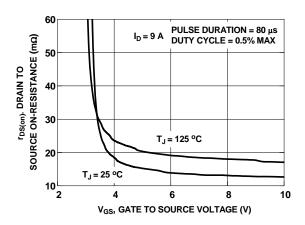


Figure 4. On-Resistance vs Gate to Source Voltage

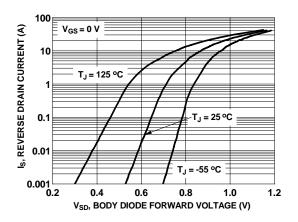


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

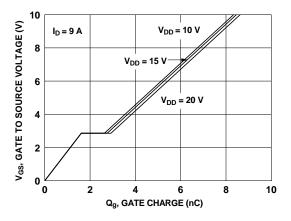


Figure 7. Gate Charge Characteristics

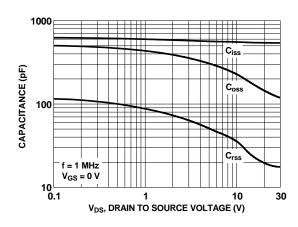


Figure 8. Capacitance vs Drain to Source Voltage

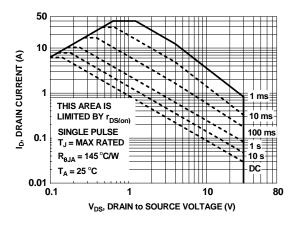


Figure 9. Forward Bias Safe Operating Area

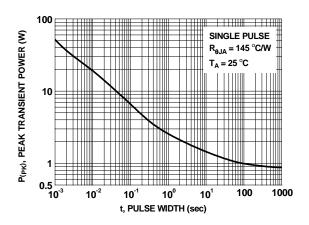


Figure 10. Single Pulse Maximum Power Dissipation

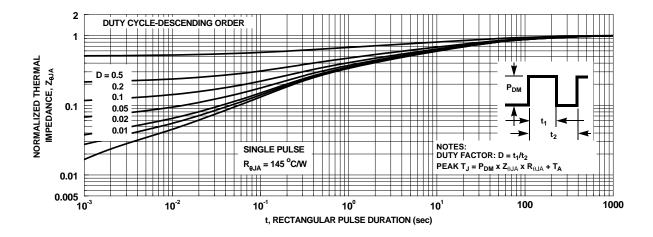
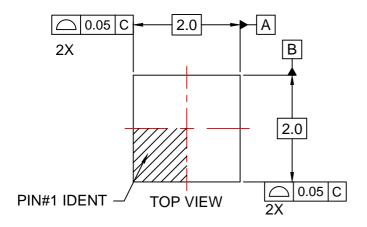
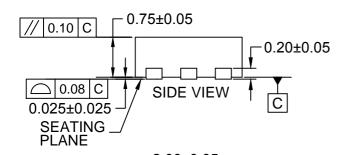
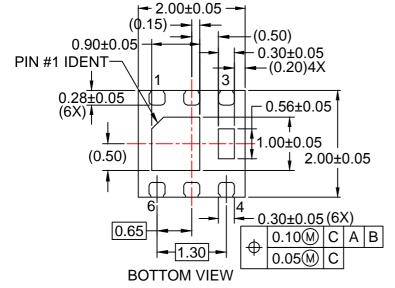


Figure 11. Junction-to-Ambient Transient Thermal Response Curve

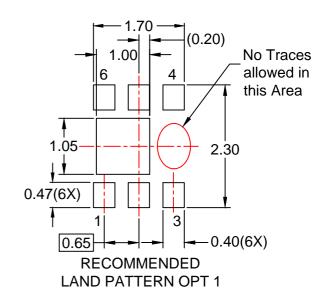


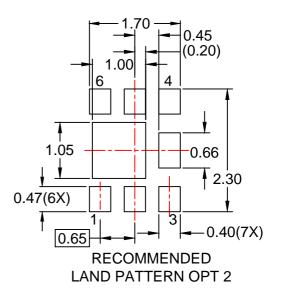




NOTES:

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